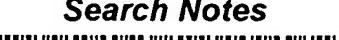


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under R examination</b>
	10/630,196	CHANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Thanh T. Nguyen	2813

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
438	149	1/30/2005	TN
438	151, 154	1/30/2005	TN
438	163-164	1/30/2005	TN